

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10534536	FUKUSHIMA ET AL.
	Examiner	Art Unit
	HENOK G HEYI	2627

SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES

Search Notes	Date	Examiner
Searched EAST and consulted with Primary Tan Dinh. Some of the subclasses searched are 369/275.1-4 and 428/64.1-4 (text search only - please see search history printout).	01/14/2009	HH
Search updated.	07/31/2009	HH

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

/HENOK G HEYI/
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